



Supporting Information

for

Kelvin probe force microscopy of the nanoscale electrical surface potential barrier of metal/semiconductor interfaces in ambient atmosphere

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Scheme of electric circuit

Schema:

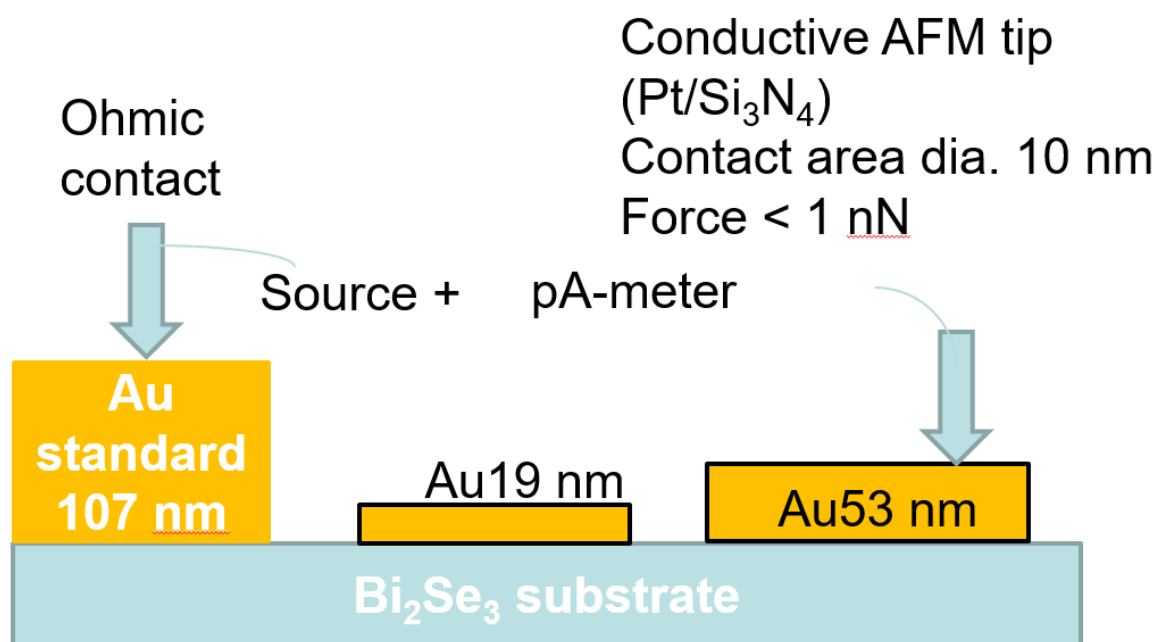


Figure S1: Scheme of electric circuit.